

April 2013

FDA59N25

N-Channel UniFETTM MOSFET 250 V, 59 A, 49 mΩ

Features

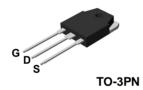
- $R_{DS(on)} = 49 \text{ m}\Omega \text{ (Max.)} @ V_{GS} = 10 \text{ V}, I_D = 29.5 \text{ A}$
- Low Gate Charge (Typ. 63 nC)
- Low C_{rss} (Typ. 70 pF)
- 100% Avalanche Tested

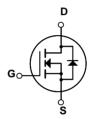
Applications

- PDP TV
- Uninterruptible Power Supply
- · AC-DC Power Supply

Description

UniFETTM MOSFET is Fairchild Semiconductor[®]'s high voltage MOSFET family based on planar stripe and DMOS technology. This MOSFET is tailored to reduce on-state resistance, and to provide better switching performance and higher avalanche energy strength. This device family is suitable for switching power converter applications such as power factor correction (PFC), flat panel display (FPD) TV power, ATX and electronic lamp ballasts.





Absolute Maximum Ratings

Symbol	Parameter		FDA59N25	Unit	
V _{DSS}	Drain-Source Voltage		250	V	
V _{DS(Avalanche)}	Repetitive Avalanche Voltage (Note 1, 2)		300	V	
I _D	Drain Current	- Continuous ($T_C = 2$ - Continuous ($T_C = 1$		59 35	A A
I _{DM}	Drain Current	- Pulsed	(Note 1)	236	А
V _{GSS}	Gate-Source voltage		±30	V	
E _{AS}	Single Pulsed Avala	inche Energy	(Note 2)	1458	mJ
I _{AR}	Avalanche Current		(Note 1)	59	A
E _{AR}	Repetitive Avalanche Energy		(Note 1)	39.2	mJ
dv/dt	Peak Diode Recove	ry dv/dt	(Note 3)	4.5	V/ns
P _D	Power Dissipation (T _C = 25°C) - Derate above 25°C		392 3.2	W W/°C	
T _{J,} T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C	
TL	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds		300	°C	

Thermal Characteristics

Symbol	Parameter	FDA59N25	Unit	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	0.32	°C/W	
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink, Typ.	0.24	°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient, Max.	40	°C/W	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDA59N25	FDA59N25	TO-3PN			30

Electrical Characteristics $T_C = 25$ °C unless otherwise noted

Symbol	Parameter	Conditions	Min.	Тур.	Max	Unit	
Off Charac	Off Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu A$	250			V	
ΔBV_{DSS} / ΔT_{J}	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C		0.25		V/°C	
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 250V, V _{GS} = 0V V _{DS} = 200V, T _C = 125°C			1 10	μA μA	
I _{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS} = 30V, V_{DS} = 0V$			100	nA	
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -30V$, $V_{DS} = 0V$			-100	nA	
On Charac	teristics						
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3.0		5.0	V	
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10V, I _D = 29.5A		0.041	0.049	Ω	
9 _{FS}	Forward Transconductance	V _{DS} = 40V, I _D = 29.5A (Note 4)		45		S	
Dynamic C	Characteristics				•	•	
C _{iss}	Input Capacitance	$V_{DS} = 25V, V_{GS} = 0V,$		3090	4020	pF	
C _{oss}	Output Capacitance	f = 1.0MHz		630	820	pF	
C _{rss}	Reverse Transfer Capacitance			70	110	pF	
Switching	Characteristics						
t _{d(on)}	Turn-On Delay Time	V _{DD} = 125V, I _D = 59A		70	150	ns	
t _r	Turn-On Rise Time	$R_{G} = 25\Omega$		480	970	ns	
t _{d(off)}	Turn-Off Delay Time			90	190	ns	
t _f	Turn-Off Fall Time	(Note 4, 5)		170	350	ns	
Q _g	Total Gate Charge	V _{DS} = 200V, I _D = 59A		63	82	nC	
Q _{gs}	Gate-Source Charge	V _{GS} = 10V		18.5		nC	
Q _{gd}	Gate-Drain Charge	(Note 4, 5)	-	30		nC	
Drain-Sour	Drain-Source Diode Characteristics and Maximum Ratings						
I _S	Maximum Continuous Drain-Source Diode Forward Current				59	Α	
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current				236	Α	
V _{SD}	Drain-Source Diode Forward Voltage $V_{GS} = 0V$, $I_S = 59A$				1.4	V	
t _{rr}	Reverse Recovery Time	V _{GS} = 0V, I _S = 59A		190		ns	
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$ (Note 4)		4.4		μС	

NOTES

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L = 0.67mH, I_{AS} = 59A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25 $^{\circ}C$
- 3. I_{SD} \leq 59A, di/dt \leq 200A/ μ s, V_{DD} \leq BV_DSS, Starting T_J = 25°C
- 4. Pulse Test: Pulse width $\leq 300 \mu s,$ Duty Cycle $\leq 2\%$
- 5. Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

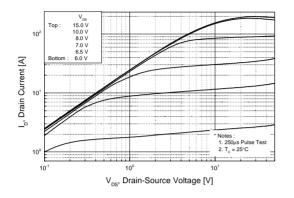


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

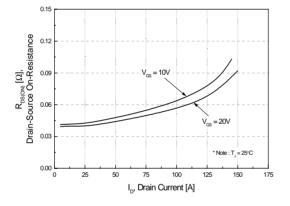


Figure 5. Capacitance Characteristics

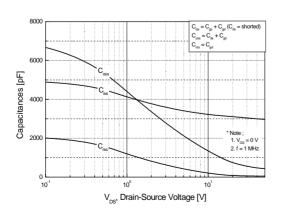


Figure 2. Transfer Characteristics

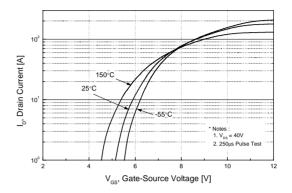


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperatue

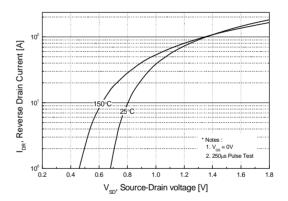
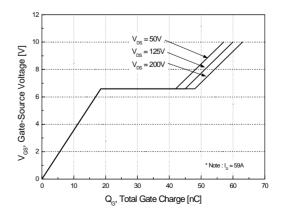


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

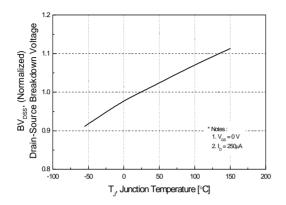


Figure 8. On-Resistance Variation vs. Temperature

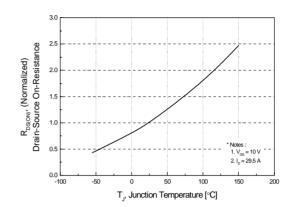


Figure 9. Maximum Safe Operating Area

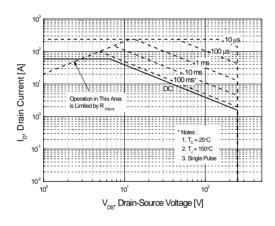


Figure 10. Maximum Drain Current vs. Case Temperature

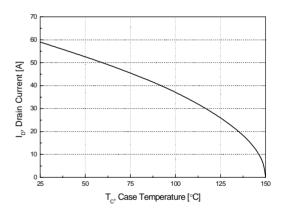
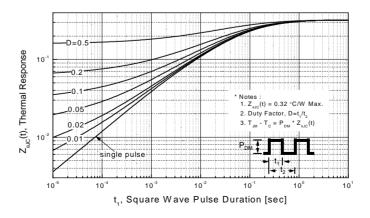
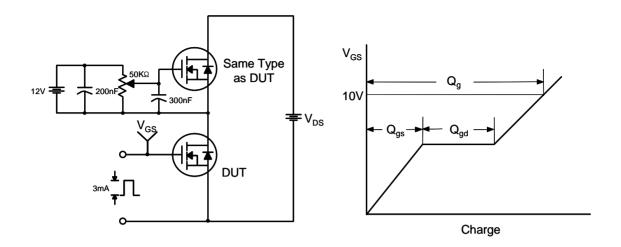


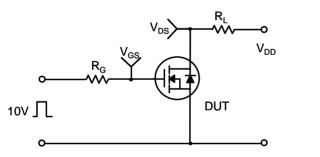
Figure 11. Transient Thermal Response Curve

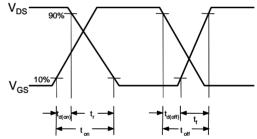


Gate Charge Test Circuit & Waveform

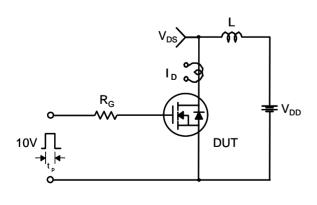


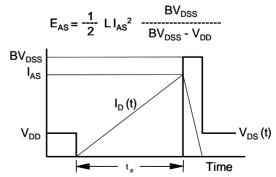
Resistive Switching Test Circuit & Waveforms



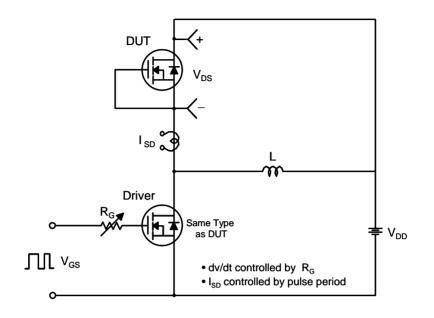


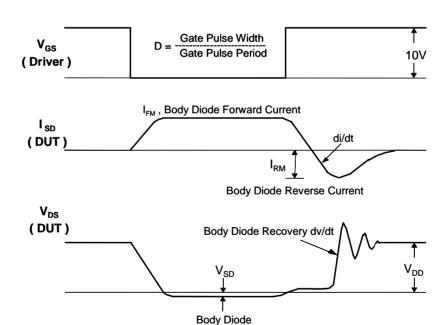
Unclamped Inductive Switching Test Circuit & Waveforms





Peak Diode Recovery dv/dt Test Circuit & Waveforms

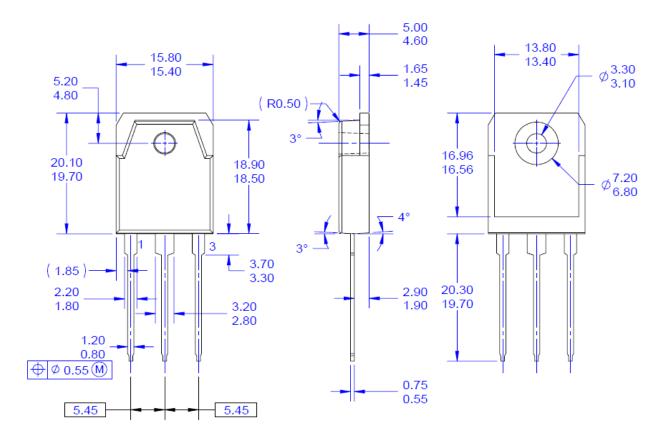


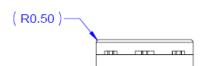


Forward Voltage Drop

Mechanical Dimensions

TO-3PN





NOTES: UNLESS OTHERWISE SPECIFIED

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